SLAS163 - FEBRUARY 1998

- Low Supply Voltage Range 2.5 V 5.5 V
- Low Operation Current, 400 μA at 1 MHz, 3 V
- Ultra-Low Power Consumption (Standby Mode Down to 0.1 μA)
- Five Power-Saving Modes
- Wake Up from Standby Mode in 6 μS
- 16-Bit RISC Architecture, 300 ns Instruction Cycle Time
- Single Common 32 kHz Crystal, Internal System Clock up to 3.8 MHz
- Integrated LCD Driver for up to 120 Segments
- Integrated Hardware Multiplier Performs Signed, Unsigned, and MAC Operations for Operands Up to 16 X 16 Bits
- Serial Communication Interface (USART), Select Asynchronous UART or Synchronous SPI by Software
- Slope A/D Converter Using External Components
- 16-Bit Timer With Five Capture/Compare Registers
- Programmable Code Protection by Security Fuse
- Family Members Include: MSP430C336 – 24 KB ROM, 1 KB RAM MSP430C337 – 32 KB ROM, 1 KB RAM MSP430P337 – 32 KB OTP, 1 KB RAM
- EPROM Version Available for Prototyping: PMS430E337
- Serial On-Board Programming
- Available in 100 Pin Quad Flat-Pack (QFP) Package, 100 Pin Ceramic Quad Flat-Pack (CFP) package (EPROM Version)

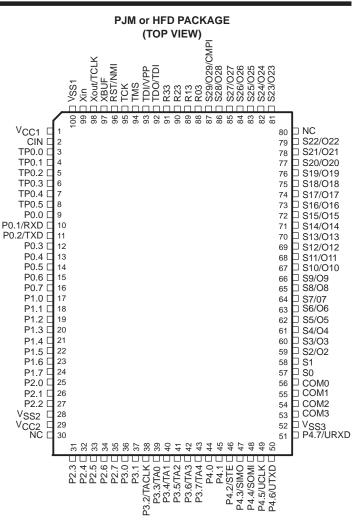
description

The Texas Instruments MSP430 series is a ultra low-power microcontroller family consisting of several devices which features different sets of modules targeted to various applications. The controller is designed to be battery operated for an extended application lifetime. With the 16-bit RISC architecture, 16 integrated registers on the CPU, and the constant generator, the MSP430 achieves maximum code efficiency. The digital-controlled oscillator, together with the frequency lock loop (FLL), provides a fast wake up from a low-power mode to an active mode in less than 6 µs. The MSP430x33x series micro-controllers have built in hardware multiplication and communication capability using asynchronous (UART) and synchronous protocols.

Typical applications of the MSP430 family include electronic gas, water, and electric meters and other sensor systems that capture analog signals, converts them to digital values, processes, displays, or transmits them to a host system.

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

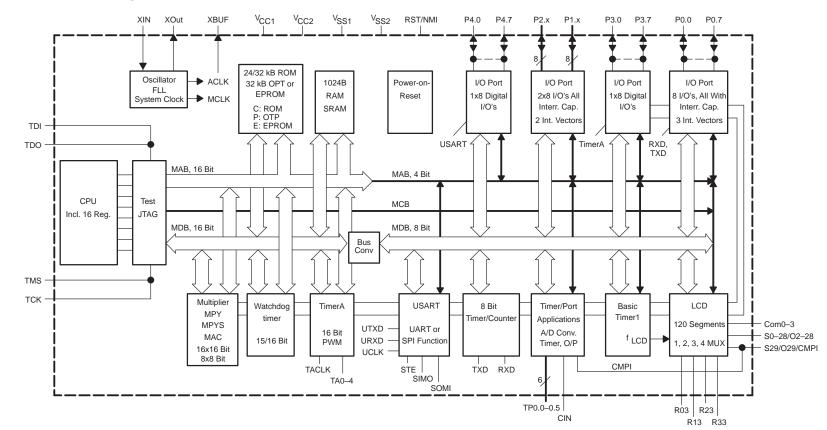






	AVAILABLE OPTIONS						
		PACKAGED DEVICES					
т	A	PLASTIC QFP (PJM)	CERAMIC QFP (HFD)				
-40°C	to 85°C	MSP430C336IPJM MSP430C337IPJM MSP430P337IPJM	_				
25	°C	—	PMS430E337HFD				

functional block diagram



SLAS163 – FEBRUARY 1998

SLAS163 - FEBRUARY 1998

Terminal Functions

TERMINAL			DECODIDION		
NAME	NO.	I/O	DESCRIPTION		
CIN	2	I	Input port. CIN is used as an enable for counter TPCNT1 – timer/port		
COM0-3	56–53	0	Common outputs. COMM0-3 are used for LCD backplanes – LCD		
P0.0	9	I/O	General purpose digital I/O		
P0.1/RXD	10	I/O	General purpose digital I/O, receive digital Input port – 8-bit timer/counter		
P0.2/TXD	11	I/O	General purpose digital I/O, transmit data output port – 8-bit timer/counter		
P0.3–P0.7	12–16	I/O	Five general purpose digital I/Os, bit 3-7		
P1.0–P1.7	17–24	I/O	Eight general purpose digital I/Os, bit 0-7		
P2.0–P2.7	25–27, 31–35	I/O	Eight general purpose digital I/Os, bit 0-7		
P3.0, P3.1	36,37	I/O	Two general purpose digital I/Os, bit 0 and bit 1		
P3.2/TACLK	38	I/O	General purpose digital I/O, clock input – timer A		
P3.3/TA0	39	I/O	General purpose digital I/O, capture I/O, or PWM output port – Timer_A CCR0		
P3.4/TA1	40	I/O	General purpose digital I/O, capture I/O, or PWM output port – Timer_A CCR1		
P3.5/TA2	41	I/O	General purpose digital I/O, capture I/O, or PWM output port – Timer_A CCR2		
P3.6/TA3	42	I/O	General purpose digital I/O, capture I/O, or PWM output port – Timer_A CCR3		
P3.7/TA4	43	I/O	General purpose digital I/O, capture I/O, or PWM output port – Timer_A CCR4		
P4.0	44	I/O	General purpose digital I/O, bit 0		
P4.1	45	I/O	General purpose digital I/O, bit 1		
P4.2/STE	46	I/O	General purpose digital I/O, slave transmit enable – USART/SPI mode		
P4.3/SIMO	47	I/O	General purpose digital I/O, slave in/master out – USART/SPI mode		
P4.4/SOMI	48	I/O	General purpose digital I/O, master in/slave out – USART/SPI mode		
P4.5/UCLK	49	I/O	General purpose digital I/O, external clock input – USART		
P4.6/UTXD	50	I/O	General purpose digital I/O, transmit data out – USART/UART mode		
P4.7/URXD	51	I/O	General purpose digital I/O, receive data in – USART/UART mode		
R03	88		Input port of fourth positive (lowest) analog LCD level (V5) – LCD		
R13	89	1	Input port of third most positive analog LCD level (V3 of V4) – LCD		
R23	90		Input port of second most positive analog LCD level (V2) – LCD		
R33	91	0	Output of most positive analog LCD level (V1) – LCD		
RST/NMI	96	1	Reset input or non-maskable interrupt input port		
S0	57	0	Segment line S0 – LCD		
S1	58	0	Segment line S1 – LCD		
S2/O2-S5/O5	59–62	0	Segment lines S2 to S5 or digital output ports, O2-O5, group 1 – LCD		
S6/O6–S9/O9	63–66	0	Segment lines S6 to S9 or digital output ports O6-O9, group 2 – LCD		
S10/O10-S13/O13	67–70	0	Segment lines S10 to S13 or digital output ports O10-O13, group 3 – LCD		
S14/O14–S17/O17	71–74	0	Segment lines S14 to S17 or digital output ports O14-O17, group 4 – LCD		
S18/O18-S21/O21	75–78	0	Segment lines S18 to S21 or digital output ports O18-O21, group 5 – LCD		
S22/O22-S25/O25	79, 81–83	0	Segment line S22 to S25 or digital output ports O22-O25, group 6 – LCD		
S26/O26-S29/O29/CMPI	84–87	0	Segment line S26 to S29 or digital output ports O26-O29, group 7 – LCD. Segment line S29 can be used as comparator input port CMPI – timer/port		
ТСК	95	I	Test clock. TCK is the clock input port for device programming and test		
TDI/VPP	93	I	Test data input. TDI/VPP is used as a data input port or input for programming voltage		



SLAS163 - FEBRUARY 1998

TERMINAL		1/0	DESCRIPTION	
NAME	NO.	1/0	DESCRIPTION	
TMS	94	I	Test mode select. TMS is used as an input port for device programming and test	
TDO/TDI	92	I/O	Test data output port. TDO/TDI data output or programming data input terminal	
TP0.0	3	0	General purpose 3-state digital output port, bit 0 - timer/port	
TP0.1	4	0	General purpose 3-state digital output port, bit 1 - timer/port	
TP0.2	5	0	General purpose 3-state digital output port, bit 2 - timer/port	
TP0.3	6	0	General purpose 3-state digital output port, bit 3 - timer/port	
TP0.4	7	0	General purpose 3-state digital output port, bit 4 - timer/port	
TP0.5	8	I/O	General purpose 3-state digital input/output port, bit 5 - timer/port	
VCC1	1		Positive supply voltage	
VCC2	29		Positive supply voltage	
VSS1	100		Ground reference	
VSS2	28		Ground reference	
VSS3	52		Ground reference	
XBUF	97	0	System clock (MCLK) or crystal clock (ACLK) output	
Xin	99	1	Input port for crystal oscillator	
Xout/TCLK	98	I/O	Output terminal of crystal oscillator or test clock input	

Terminal Functions

short-form description

processing unit

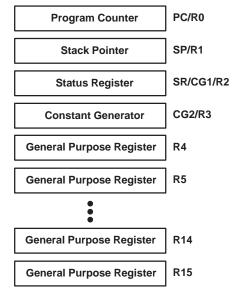
The processing unit is based on a consistent and orthogonal designed CPU and instruction set. This design structure results in a RISC-like architecture, highly transparent to the application development and is distinguished due to ease of programming. All operations, other than program-flow instructions consequently are performed as register operations in conjunction with seven addressing modes for source and four modes for destination operand.

cpu registers

Sixteen registers are located inside the CPU, providing reduced instruction execution time. This reduces a register-register operation execution time to one cycle of the processor frequency.

Four of the registers are reserved for special use as a program counter, a stack pointer, a status register and a constant generator. The remaining registers are available as general purpose registers.

Peripherals are connected to the CPU using a data address and control bus and can be handled easily with all instructions for memory manipulation.





instruction set

The instruction set for this register-register architecture provides a powerful and easy-to-use assembly language. The instruction set consists of 52 instructions, with three formats and seven addressing modes. Table 1 provides a summation and example of the three types of instruction formats; the addressing modes are listed in Table 2.

Table 1. Instruction Word Formats

Dual operands, source-destination	e.g. ADD R4,R5	$R4 + R5 \rightarrow R5$
Single operands, destination only	e.g. CALL R8	$PC \to (TOS), SR \to (TOS), R8 \to PC$
Relative jump, un-/conditional	e.g. JNE	Jump-on equal bit = 0

Instructions that can operate on both word and byte data are differentiated by the suffix '.B' when a byte operation is required.

Examples:

Instructions for word operation:				
MOV	ede,toni			
ADD	#235h,&MEM			
PUSH	R5			
SWPB	R5			

Instructions for byte operation:					
MOV.B	ede,toni				
ADD.B	#35h,&MEM				
PUSH.B	R5				

Table 2. Address Mode Descriptions

ADDRESS MODE	S	D	SYNTAX	EXAMPLE	OPERATION
register	\checkmark	\checkmark	MOV Rs,Rd	MOV R10,R11	$R10 \rightarrow R11$
indexed	\checkmark	\checkmark	MOV X(Rn),Y(Rm)	MOV 2(R5),6(R6)	$M(2+R5) \rightarrow M(6+R6)$
symbolic (PC relative)	\checkmark	\checkmark	MOV EDE,TONI		$M(EDE) \rightarrow M(TONI)$
absolute	\checkmark	\checkmark	MOV &MEM,&TCDAT		$M(MEM) \rightarrow M(TCDAT)$
indirect	\checkmark		MOV @Rn,Y(Rm)	MOV @R10,Tab(R6)	$M(R10) \rightarrow M(Tab+R6)$
indirect autoincrement	V		MOV @Rn+,Rm	MOV @R10+,R11	$ \begin{array}{c} M(R10) \rightarrow R11 \\ R10 + 2 \rightarrow R10 \end{array} $
immediate	\checkmark		MOV #X,TONI	MOV #45,TONI	$#45 \rightarrow M(TONI)$

NOTE 1: S = source, D = destination.

Computed branches (BR) and subroutine calls (CALL) instructions use the same addressing modes as the other instructions. These addressing modes provide *indirect* addressing, ideally suited for computed branches and calls. The full use of this programming capability permits a program structure different from conventional 8- and 16-bit controllers. For example, numerous routines can easily be designed to deal with pointers and stacks instead of using Flag type programs for flow control.



SLAS163 - FEBRUARY 1998

operation modes and interrupts

The MSP430 operating modes support various advanced requirements for ultra-low power and ultra-low energy consumption. This is achieved by the intelligent management of the operations during the different module operation modes and CPU states. The requirements are fully supported during interrupt event handling. An interrupt event awakens the system from each of the various operating modes and returns with the RETI instruction to the mode that was selected before the interrupt event. The clocks used are ACLK and MCLK. ACLK is the crystal frequency and MCLK is a multiple of ACLK and is used as the system clock.

The following five operating modes are supported:

- Active mode (AM). The CPU is enabled with different combinations of active peripheral modules.
- Low power mode 0 (LPM0). The CPU is disabled, peripheral operation continues, ACLK and MCLK signals are active, and loop control for MCLK is active.
- Low power mode 1 (LPM1). The CPU is disabled, peripheral operation continues, ACLK and MCLK signals are active, and loop control for MCLK is inactive.
- Low power mode 2 (LMP2). The CPU is disabled, peripheral operation continues, ACLK signal is active, and MCLK and loop control for MCLK are inactive.
- Low power mode 3 (LMP3). The CPU is disabled, peripheral operation continues, ACLK signal is active, MCLK and loop control for MCLK are inactive, and the dc generator for the digital controlled oscillator (DCO) (→MCLK generator) is switched off.
- Low power mode 4 (LMP4). The CPU is disabled, peripheral operation continues, ACLK signal is inactive (crystal oscillator stopped), MCLK and loop control for MCLK are inactive, and the dc generator for the DCO is switched off.

The special function registers (SFR) include module-enable bits that stop or enable the operation of the specific peripheral module. All registers of the peripherals may be accessed if the operational function is stopped or enabled. However, some peripheral current-saving functions are accessed through the state of local register bits. An example is the enable/disable of the analog voltage generator in the LCD peripheral which is turned on or off using one register bit.

The most general bits that influence current consumption and support fast turn-on from low power operating modes are located in the status register (SR). Four of these bits control the CPU and the system clock generator: SCG1, SCG0, OscOff, and CPUOff.

15	9	8	7							0
Reserved Fo Enhancer		v	SCG1	SCG0	OscOff	CPUOff	GIE	N	z	с



interrupts

Software determines the activation of interrupts through the monitoring of hardware set interrupt flag status bits, the control of specific interrupt enable bits in SRs, the establishment of interrupt vectors, and the programming of interrupt handlers. The interrupt vectors and the power-up starting address are located in ROM address locations 0FFFFh through 0FFE0h. Each vector contains the 16-bit address of the appropriate interrupt handler instruction sequence. Table 3 provides a summation of interrupt functions and addresses.



SLAS163 - FEBRUARY 1998

INTERRUPT SOURCE	INTERRUPT FLAG	SYSTEM INTERRUPT	WORD ADDRESS	PRIORITY
Power-up, external reset, Watchdog	WDTIFG	Reset	0FFFEh	15, highest
NMI, Oscillator fault	NMIIFG (see Note 2) OFIFG (see Note 2)	non-maskable (non)-maskable	0FFFCh	14
Dedicated I/O	P0IFG.0	maskable	0FFFAh	13
Dedicated I/O	P0IFG.1	maskable	0FFF8h	12
		maskable	0FFF6h	11
Watchdog timer	WDTIFG	maskable	0FFF4h	10
Timer_A	CCIFG0 (see Note 3)	maskable	0FFF2h	9
Timer_A	TAIFG (see Note 3)	maskable	0FFF0h	8
UART Receive	URXIFG	maskable	0FFEEh	7
UART Transmit	UTXIFG	maskable	0FFECh	6
			0FFEAh	5
Timer/Port	See Note 3	maskable	0FFE8h	4
I/O Port P2	P2IFG.07 (see Note 2)	maskable	0FFE6h	3
I/O Port P1	P1IFG.07 (see Note 2)	maskable	0FFE4h	2
Basic Timer	BTIFG	maskable	0FFE2h	1
I/O Port P0	P0IFG.27 (see Note 2)	maskable	0FFE0h	0, lowest

Table 3. Interrupt Functions and Addresses

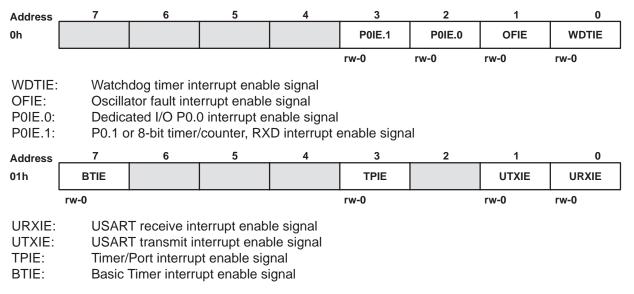
NOTES: 2. Multiple source flags

3. Interrupt flags are located in the module

special function registers

Most interrupt and module enable bits are collected into the lowest address space. Special function register bits that are not allocated to a functional purpose are not physically present in the device. Simple SW access is provided with this arrangement.

interrupt enable 1 and 2





SLAS163 – FEBRUARY 1998

Number Number Number PoiFG.1 PoiFG.0 OFIFG WDTIF 02h rw-0 rw-0 rw-0 rw-0 rw-1 rw-0 WDTIFG: Set on overflow or security key violation or Reset on VCC1 power-on or reset condition at 'RST/NMI-pin rw-0 rw-1 rw-0 OFIFG: Flag set on oscillator fault P0.01FG: Dedicated I/O P0.0 P0.11FG: P0.1 or 8-bit timer/counter, RXD NMIIFG: Signal at 'RST/NMI-pin Address 7 6 5 4 3 2 1 0 Address 7 6 5 4 3 2 1 0 URXIFG: USART receive flag UTXIFG: USART transmit flag BTIFG: Basic Timer flag odule enable registers 1 and 2 Address 7 6 5 4 3 2 1 0 Address 7 6 5 4 3 2 1 0 obh Image: Set on se		registers 1	6	5	4	3	2	1	0
rw-0 rw-0 rw-0 rw-0 rw-0 rw-1 rw-0 WDTIFG: Set on overflow or security key violation or Reset on VCC1 power-on or reset condition at 'RST/NMI-pin OFIFG: Flag set on oscillator fault P0.01FG: Dedicated I/O P0.0 P0.11FG: P0.1 or 8-bit timer/counter, RXD NMIIFG: Signal at 'RST/NMI-pin Address 7 6 5 4 3 2 1 0 03h BTIFG UTXIFG UXIFG UXIFG UXIFG vw rw-1 rw-0 URXIFG: USART receive flag UTXIFG: USART transmit flag BTIFG: Basic Timer flag odule enable registers 1 and 2 Address 7 6 5 4 3 2 1 0 Address 7 6 5 4 3 2 1 0		1	0	5				l III	1
WDTIFG: Set on overflow or security key violation or Reset on VCC1 power-on or reset condition at 'RST/NMI-pin OFIFG: Flag set on oscillator fault P0.0IFG: Dedicated I/O P0.0 P0.1IFG: P0.1 or 8-bit timer/counter, RXD NMIIFG: Signal at 'RST/NMI-pin Address 7 6 5 4 3 2 1 0 O3h BTIFG UTXIFG URXIF rw rw-1 rw-0 URXIFG: USART receive flag UTXIFG: USART transmit flag BTIFG: Basic Timer flag odule enable registers 1 and 2 Address 7 6 5 4 3 2 1 0 Address 7 6 5 4 3 2 1 0 O4h UTXIFG UTXIF URXIF rw-0 rw-0 VTXIFG UTXIF UTXIF URXIF O5h UTXE UTXE URXIF									
Address 7 6 5 4 3 2 1 0 03h BTIFG UTXIFG UTXIFG UTXIFG URXIF rw rw-1 rw-0 URXIFG: USART receive flag UTXIFG: USART transmit flag BTIFG: Basic Timer flag odule enable registers 1 and 2 Address 7 6 5 4 3 2 1 0 Address 7 6 5 4 3 2 1 0 Address 7 6 5 4 3 2 1 0 Address 7 6 5 4 3 2 1 0 05h Image: Construct on the state on	 WDTIFG: Set on overflow or security key violation or Reset on VCC1 power-on or reset condition at 'RST/NMI-pin OFIFG: Flag set on oscillator fault P0.0IFG: Dedicated I/O P0.0 P0.1IFG: P0.1 or 8-bit timer/counter, RXD 								
03h BTIFG URXIFG UTXIFG URXIFG rw rw-1 rw-0 URXIFG: USART receive flag rw-1 rw-0 UTXIFG: USART transmit flag BTIFG: Basic Timer flag bdule enable registers 1 and 2 4 3 2 1 0 Address 7 6 5 4 3 2 1 0 Address 7 6 5 4 3 2 1 0 Address 7 6 5 4 3 2 1 0 O5h 7 6 5 4 3 2 1 0 rw-0 rw-0 rw-0 rw-0 rw-0 rw-0 rw-0		0			4	3	2	1	0
URXIFG: USART receive flag UTXIFG: USART transmit flag BTIFG: Basic Timer flag odule enable registers 1 and 2 Address 7 6 5 4 3 2 1 0 04h Address 7 6 5 4 3 2 1 0 05h UTXE URXE rw-0 rw-0	ſ	BTIFG						UTXIFG	URXIFG
UTXIFG: USART transmit flag BTIFG: Basic Timer flag odule enable registers 1 and 2 Address 7 6 5 4 3 2 1 0 04h Address 7 6 5 4 3 2 1 0 05h UTXE URXE rw-0 rw-0	L	rw						rw-1	rw-0
Address 7 6 5 4 3 2 1 0 04h 1 <td< td=""><td>UTXIFG</td><td>: USAR</td><td colspan="6">USART transmit flag</td><td></td></td<>	UTXIFG	: USAR	USART transmit flag						
Address 7 6 5 4 3 2 1 0 Address 7 6 5 4 3 2 1 0 05h UTXE UTXE UTXE UTXE UTXE UTXE	dule enab	le registers	s 1 and 2						
Address 7 6 5 4 3 2 1 0 05h UTXE URXE rw-0 rw-0	Address	7	6	5	4	3	2	1	0
05h UTXE URXE rw-0 rw-0	04h								
05h UTXE URXE rw-0 rw-0	L								•
rw-0 rw-0	Address	7	6	5	4	3	2	1	0
	05h							UTXE	URXE
UTXE: USART transmit enable	-							rw-0	rw-0
	UTXE:	USAR	T transmit e	nable					

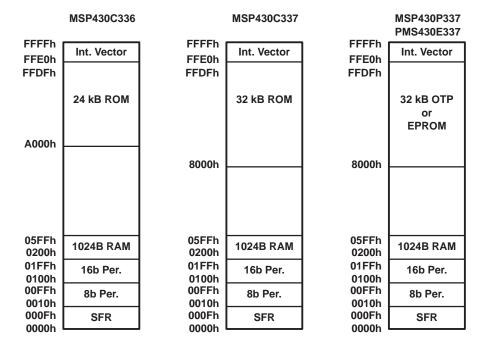
URXE: USART receive enable



module enable registers 1 and 2 (continued)

Legend rw: rw-0: Bit can be read and written Bit can be read and written. It is reset by PUC SFR bit not present in device

ROM memory organization



peripherals

Peripherals are connected to the CPU through a data, address, and control bus and can be handled easily with instructions for memory manipulation.

oscillator and system clock

Two clocks are used in the system, the system (master) clock (MCLK) and the auxiliary clock (ACLK). The MCLK is a multiple of the ACLK. The ACLK runs with the crystal oscillator frequency. The special design of the oscillator supports the feature of low current consumption and the use of a 32 768 Hz crystal. The crystal is connected across two terminals without any other external components being required.

The oscillator starts after applying VCC, due to a reset of the control bit (OscOff) in the status register (SR). It can be stopped by setting the OscOff bit to a 1. The enabled clock signals ACLK, ACLK/2, ACLK/4, OR MCLK are accessible for use by external devices at output terminal XBUF.

The controller system clocks have to deal with different requirements according to the application and system condition. Requirements include:

- High frequency in order to react quickly to system hardware requests or events
- Low frequency in order to minimize current consumption, EMI, etc.
- Stable frequency for timer applications e.g. real time clock (RTC)
- Enable start-stop operation with minimum delay to operation function.



SLAS163 – FEBRUARY 1998

These requirements cannot all be met with fast frequency high-Q crystals or with RC-type low-Q oscillators. The compromise selected for the MSP430 uses a low-crystal frequency which is multiplied to achieve the desired nominal operating range:

 $f_{(system)} = N \times f_{(crystal)}$

The crystal frequency multiplication is acheived with a frequency locked loop (FLL) technique. The factor N is recommended to be 32, 64, 96, or 128 depending on the maximum clock frequency and the electrical characteristics provided by this datasheet. The FLL technique, in combination with a digital controlled oscillator (DCO) provides immediate start-up capability together with long term crystal stability. The frequency variation of the DCO with the FLL inactive is typically 330 ppm which means that with a cycle time of 1 µs the maximum possible variation is 0.33 ns. For more precise timing, the FLL can be used which forces longer cycle times if the previous cycle time was shorter than the selected one. This switching of cycle times makes it possible to meet the chosen system frequency over a long period of time.

The start-up operation of the system clock depends on the previous machine state. During a PUC, the DCO is reset to its lowest possible frequency. The control logic starts operation immediately after recognition of PUC.

multiplication

The multiplication operation is supported by a dedicated peripheral module. The module performs 16x16, 16x8, 8x16, and 8x8 bit operations. The module is capable of supporting signed and unsigned multiplication as well as unsigned multiply and accumulate operations. The result of an operation can be accessed immediately after the operands have been loaded into the peripheral registers. No additional clock cycles are required.

digital I/O

Five eight-bit I/O ports (P0 thru P4) are implemented. Port P0 has six control registers, P1 and P2 have seven control registers, and P3 and P4 modules have four control registers to give maximum flexibility of digital input/output to the application:

- Individual I/O bits are independently programable.
- Any combination of input, output, and interrupt conditions is possible.
- Interrupt processing of external events is fully implemented for all eight bits of the P0, P1, and P2 ports.
- Read/write access is available to all registers by all instructions.

The seven registers are:

- Input register contains information at the pins
- Output register contains output information
- Direction register controls direction
- Interrupt edge select contains input signal change necessary for interrupt
- Interrupt flags indicates if interrupt(s) are pending
- Interrupt enable contains interrupt enable pins
- Function select determines if pin(s) used by module or port

These registers contain eight bits each with the exception of the the interrupt flag register and the interrupt enable register which are 6 bits each. The two least significant bit (LSBs) of the interrupt flag and enable registers are located in the special function register (SFR). Five interrupt vectors are implemented, one for Port P0.0, one for Port P0.1, one commonly used for any interrupt event on Port P0.2 to Port P0.7, one commonly used for any interrupt event on Port P1.0 to Port P1.7, and one commonly used for any interrupt event on Port P2.0.



SLAS163 - FEBRUARY 1998

LCD drive

Liquid crystal displays (LCDs) for static, 2-, 3-, and 4-MUX operation can be driven directly. The operation of the controller LCD logic is defined by software through memory-bit manipulation. LCD memory is part of the LCD module, not part of data memory. Eight mode and control bits define the operation and current consumption of the LCD drive. The information for the individual digits can be easily obtained using table programming techniques combined with the proper addressing mode. The segment information is stored into LCD memory using instructions for memory manipulation.

The drive capability is defined by the external resistor divider that supports analog levels for 2-, 3-, and 4-MUX operation. Groups of the LCD segment lines can be selected for digital output signals. The MSP430x33x configuration has four common lines, 30 segment lines, and four terminals for adjusting the analog levels.

basic timer1

The Basic Timer1 (BT1) divides the frequency of MCLK or ACLK, as selected with the SSEL bit, to provide low frequency control signals. This is done within the system by one central divider, the basic timer, to support low current applications. The BTCTL control register contains the flags which control or select the different operational functions. When the supply voltage is applied or when a reset of the device (RST/NMI pin), a watchdog overflow, or a watchdog security key violation occurrs, all bits in the register hold undefined or unchanged status. The user software usually configures the operational conditions on the BT during initialization.

The basic timer has two eight bit timers which can be cascaded to a sixteen bit timer. Both timers can be read and written by software. Two bits in the SFR address range handle the system control interaction according to the function implemented in the basic timer. These two bits are the Basic Timer Interrupt Flag (BTIFG) and the Basic Timer Interrupt Enable (BTIE) bit.

watchdog timer

The primary function of the Watchdog Timer (WDT) module is to perform a controlled system restart after a S/W upset has occurred. If the selected time interval expires, a system reset is generated. If this watchdog function is not needed in an application, the module can work as an interval timer, which generates an interrupt after the selected time interval.

The watchdog timer counter (WDTCNT) is a 15/16-bit upcounter which is not directly accessible by software. The WDTCNT is controlled using the watchdog timer control register (WDTCTL), which is an 8-bit read/write register. Writing to WDTCTL, in both operating modes (watchdog or timer) is only possible by using the correct password in the high-byte. The low-byte stores data written to the WDTCTL. The high-byte password is 05Ah. If any value other than 05Ah is written to the high-byte of the WDTCTL, a system reset PUC is generated. *When the password is read its value is 069h that minimizes accidental write operations to the WDTCTL register.* A read-access to WDTCTL is only possible by writing 05Ah as the password in the high-byte of the WDTCTL. This avoids an accidental write-access on the WDTCTL. Additionally to the watchdog timer control bits, there are two bits included in the WDTCTL that configure the NMI pin.

USART

The universal synchronous/asynchronous interface is a dedicated peripheral module which provides serial communications. The USART supports synchronous SPI (3 or 4 pin), and asynchronous UART communications protocols, using double buffered transmit and receive channels. Data streams of 7 or 8 bits in length can be transferred at a rate determined by the program, or by a rate defined by an external clock. Low power applications are optimized by UART mode options which allow for the receipt of only the first byte of a complete frame. The applications software then decides if the succeeding data is to be processed. This option reduces power consumption.

Two dedicated interrupt vectors are assigned to the USART module, one for the receive and one for the transmit channel.



SLAS163 – FEBRUARY 1998

timer/port

The timer/port module has two 8-bit counters, an input that triggers one counter and six digital outputs with 3-state capability. Both counters have an independent clock selector for selecting an external signal or one of the internal clocks (ACLK or MCLK). One of the counters has an extended control capability to halt, count continuously, or gate the counter by selecting one of two external signals. This gate signal sets the interrupt flag if an external signal is selected and the gate stops the counter.

Both timers can be read to and written from by software. The two 8-bit counters can be cascaded to form a 16-bit counter. A common interrupt vector is implemented. The interrupt flag can be set by three events in the 8-bit counter mode (gate signal or overflow from the counters) or by two events in the 16-bit counter mode (gate signal or overflow from the cascaded counter).

slope A/D conversion

Slope A/D conversion is accomplished with the timer/port module using external resistor(s) for reference (R_{ref}), external resistor(s) to the measured (R_{meas}), and an external capacitor. The external components are driven by software in such a way that the internal counter measures the time that is needed to charge or discharge the capacitor. The reference resistor's (R_{ref}) charge or discharge time is represented by N_{ref} counts. The unknown resistors (R_{meas}) charge or discharge time is represented by N_{meas} counts. The unknown resistor's value R_{meas} is the value of R_{ref} multiplied by the relative number of counts (N_{meas}/N_{ref}). This value determines resistive sensor values that corresponds to the physical data, for example temperature, when an NTC or PTC resistor is used.

timer_a

The timer_a module offers one sixteen bit counter and five capture/compare registers. The timer clock source can be selected to come from an external source TACLK (SSEL=0), the ACLK (SSEL=1), or MCLK (SSEL=2 or SSEL=3). The clock source can be divided by one, two, four or eight. The timer can be fully controlled (in word mode) since it can be halted, read, and written. It can be stopped, run continuously, count up, or count up/down using one compare block to determine the period. The five capture/compare blocks are configured by the application software to run in either capture or compare mode.

The capture mode is primarily used to measure external or internal events with any combination of positive, negative, or both edges of the clock. The clock can also be stopped in capture mode by software. One external event (CCISx=0) per capture block can be selected. If CCISx=1, the ACLK is the capture signal; and if CCISx=2 or CCISx=3, software capture is chosen.

The compare mode is primarily used to generate timing for the software or application hardware or to generate pulse-width modulated output signals for various purposes like D/A conversion functions or motor control. An individual output module, which can run independently of the compare function or is triggered in several ways, is assigned to each of the five capture/compare registers.

Two interrupt vectors are used by the timer_a module. One individual vector is assigned to capture/compare block CCR0 and one common interrupt vector is assigned to the timer and the other four capture/compare blocks. The five interrupt events using the common vector are identified by an individual interrupt vector word. The interrupt vector word is used to add an offset to the program counter to continue the interrupt handler software at the correct location. This simplifies the interrupt handler and gives each interrupt event the same interrupt handler overhead of 5 cycles.



8-bit timer/counter

The 8-bit interval timer supports three major functions for applications:

- Serial communication or data exchange
- Plus counting or plus accumulation
- Timer

8-bit timer/counter (continued)

The 8-bit timer/counter peripheral includes the following major blocks: an 8-bit Up-Counter with preload register, an 8-bit Control Register, an Input clock selector, an Edge detection (e.g. Start bit detection for asynchronous protocols), and an input and output data latch, triggered by the carry-out-signal from the 8-bit counter.

The 8-bit counter counts up with an input clock which is selected by two control bits from the control register. The four possible clock sources are MCLK, ACLK, the external signal from terminal P0.1, and the signal from the logical .AND. of MCLK and terminal P0.1.

Two counter inputs (load, enable) control the counter operation. The load input controls load operations. A write-access to the counter results in loading the content of the preload register into the counter. The software writes or reads the preload register with all instructions. The preload register acts as a buffer and can be written immediately after the load of the counter is completed. The enable input enables the count operation. When the enable signal is set to high, the counter will count-up each time a positive clock edge is applied to the clock input of the counter.



SLAS163 – FEBRUARY 1998

peripheral file map

Peripherals with byte access

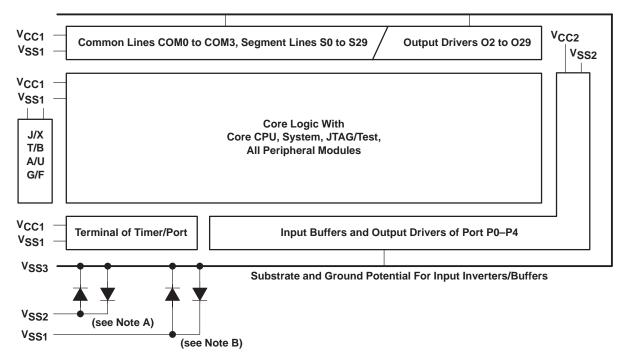
i enprierais with	II byte access				
UART	Transmit Buffer, UTXBUF	077h	Port P3	Port P3 Selection, P3SEL	01Bh
	Receive Buffer, URXBUF	076h		Port P3 Direction, P3DIR	01Ah
	Baud Rate, UBR1	075h		Port P3 Output, P3OUT	019h
	Baud Rate, UBR0	074h		Port P3 Input, P3IN	018h
	Modulation Control, UMCTL	073h	Port P0	Port P0 Interrupt Enable, P0IE	015h
	Receive Control, URCTL	072h		Port P0 Interrupt Edge Select, P0IES	014h
	Transmit Control, UTCTL	071h		Port P0 Interrupt Flag, P0IFG	013h
	UART Control, UCTL	070h		Port P0 Direction, P0DIR	012h
EPROM	EPROM Control, EPCTL	054h		Port P0 Output, P0OUT	011h
Crystal Buffer	Crystal Buffer Control, CBCTL	053h		Port P0 Input, P0IN	010h
System Clock	SCG Frequency Control, SCFQCTL	052h	Special	SFR Interrupt Flag2, IFG2	003h
	SCG Frequency Integrator, SCFI1	051h	Function	SFR Interrupt Flag1, IFG1	002h
	SCG Frequency Integrator, SCFI0	050h		SFR Interrupt Enable2, IE2	001h
Timer/Port	Timer Port Enable, TPE	04Fh		SFR Interrupt Enable1, IE1	000h
	Timer Port Data, TPD	04Eh	Peripherals wit	h word access	
	Timer Port Counter2, TPCNT2	04Dh	Multiply	Sum Extend, SumExt	013Eh
	Timer Port Counter1, TPCNT1	04Ch		Result High Word, ResHi	013Ch
	Timer Port Control, TPCTL	04Bh		Result Low Word, ResLo	013Ah
Basic Timer	Basic Timer Counter2, BTCNT2	047h		Second Operand, OP_2	0138h
	Basic Timer Counter1, BTCNT1	046h		Reserved	0136h
	Basic Timer Control, BTCTL	040h		Multiply+Accumulate/Op.1, MAC	0134h
8-bit T/C	8-bit Timer/Counter Data, TCDAT	044h		Multiply Signed/Operand1, MPYS	0132h
	8-bit Timer/Counter Preload, TCPLD	043h		Multiply Unsigned/Operand1, MPY	0130h
	8-bit Timer/Counter Control, TCCTL	042h	Watchdog	Watchdog/Timer Control, WDTCTL	0120h
LCD	LCD Memory 15, LCDM15	03Fh	Timer_A	Timer_A Interrupt Vector, TAIV	012Eh
	:		—	Timer_A Control, TACTL	0160h
	LCD Memory 1, LCDM1	031h		Cap/Com Control, CCTL0	0162h
	LCD Control & Mode, LCDC	030h		Cap/Com Control, CCTL1	0164h
Port P2	Port P2 Selection, P2SEL	02Eh		Cap/Com Control, CCTL2	0166h
	Port P2 Interrupt Enable, P2IE	02Dh		Cap/Com Control, CCTL3	0168h
	Port P2 Interrupt Edge Select, P2IES	02Ch		Cap/Com Control, CCTL4	016Ah
	Port P2 Interrupt Flag, P2IFG	02Bh		Reserved	016Ch
	Port P2 Direction, P2DIR	02Ah		Reserved	016Eh
	Port P2 Output, P2OUT	029h		Timer_A Register, TAR	0170h
	Port P2 Input, P2IN	028h		Cap/Com Register, CCR0	0172h
Port P1	Port P1 Selection, P1SEL	026h		Cap/Com Register, CCR1	0174h
	Port P1 Interrupt Enable, P1IE	025h		Cap/Com Register, CCR2	0176h
	Port P1 Interrupt Edge Select, P1IES	024h		Cap/Com Register, CCR3	0178h
	Port P1 Interrupt Flag, P1IFG	023h		Cap/Com Register, CCR4	017Ah
	Port P1 Direction, P1DIR	023h 022h		Reserved	017Ch
	Port P1 Output, P1OUT	02211 021h		Reserved	017Eh
	Port P1 Input, P1IN	021h 020h		Reserved	UTTEN
Port P4	Port P4 Selection, P4SEL	0201 01Fh			
	Port P4 Selection, P4SEL Port P4 Direction, P4DIR				
		01Eh			
	Port P4 Output, P4OUT	01D			
	Port P4 Input, P4IN	01Ch			



SLAS163 - FEBRUARY 1998

absol	ute	maximum	ratings

Supply voltage range, between V _{CC} terminalsC).3 V to 0.3 V
Supply voltage range, between V _{SS} terminalsC).3 V to 0.3 V
Input voltage range, V _{CC1} to any VSS terminal	–0.3 V to 6 V
Input voltage range, V _{CC2} to any VSS terminal	–0.3 V to 6 V
Input voltage range to any terminal (referenced to VSS)0.3 V to	V _{CC} + 0.3 V
Diode current at any device terminal	±2 mA
Storage temperature range, T _{stg} , (unprogrammed device)	5°C to 150°C
Storage temperature range, T _{stg} , (unprogrammed device)	40°C to 85°C



NOTES: A. Ground potential for all port output drivers and input terminals, excluding first inverter/buffer B. Ground potential for entire device core logic and peripheral modules

Figure 1. Supply Voltage Interconnection



SLAS163 - FEBRUARY 1998

recommended operating conditions

PARAMETER		MIN	NOM	MAX	UNIT
Supply voltage, V _{CC} , (MSP430C33x)		2.5		5.5	V
Supply voltage, V _{CC} , (MSP430E/P33x)		2.7	3	5.5	V
Supply voltage, VSS		0	0	0	V
	TMS430C33x, TMS430P33x	-40		85	°C
Operating free-air temperature range T _A	PMS430E33x		25		Ĵ
XTAL frequency f(XTAL) (signal ACLK)			32 768		HZ
	V _{CC} = 3 V	DC		1.65	MHz
Processor frequency (signal MCLK), fsystem	$V_{CC} = 5 V$	DC		3.8	MHz

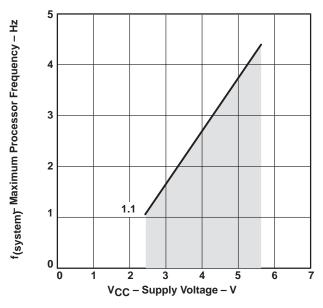


Figure 2. Frequency vs. Supply Voltage



SLAS163 – FEBRUARY 1998

electrical characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

	PARAMETER		TEST CON	DITIONS	MIN NOM	MAX	UNIT
		C336/7	$T_A = -40^{\circ}C + 85^{\circ}C$,	$V_{CC} = 3 V$	400	500	
L	Active Mode	0330/7	$T_A = -40^{\circ}C + 85^{\circ}C$,	$V_{CC} = 5 V$	800	900	μA
I(AM)	Active Mode	P337	$T_A = -40^{\circ}C + 85^{\circ}C$,	$V_{CC} = 3 V$	3	6	mA
		F337	$T_A = -40^{\circ}C + 85^{\circ}C$,	$V_{CC} = 5 V$	10	12	IIIA
		C336/7	$T_A = -40^{\circ}C + 85^{\circ}C$,	$V_{CC} = 3 V$	50	70	
konuom	Low power mode, (LPM0,1)	0330/7	$T_A = -40^{\circ}C + 85^{\circ}C$,	$V_{CC} = 5 V$	100	130	
I(CPUOff)		P337	$T_A = -40^{\circ}C + 85^{\circ}C$,	$V_{CC} = 3 V$	70	110	μA
			$T_A = -40^{\circ}C + 85^{\circ}C$,	$V_{CC} = 5 V$	150	200	
Lu Low power mode (LDM2)		$T_A = -40^{\circ}C + 85^{\circ}C$,	$V_{CC} = 3 V$	7	12		
l(LPM2)	Low power mode, (LPM2)		$T_A = -40^{\circ}C + 85^{\circ}C$,	$V_{CC} = 5 V$	18	25	μA
			$T_A = -40^{\circ}C$		2.0	3.5	
			T _A = 25°C	$V_{CC} = 3 V$	2.0	3.5	
14	Low power mode (LDM2)		T _A = 85°C		1.6	3.5	
I(LPM3)	Low power mode, (LPM3)		$T_A = -40^{\circ}C$		5.2	10	μA
			T _A = 25°C	$V_{CC} = 5 V$	4.2	10	
			T _A = 85°C		4.0	10	
			$T_A = -40^{\circ}C$		0.1	0.8	
l(LPM4)	Low power mode, (LPM4)		T _A = 25°C	$V_{CC} = 3 V/5 V$	0.1	0.8	μA
、			T _A = 85°C		0.4	1.5	

supply current (into V_{CC}) excluding external current (f_(system) = 1 MHz) (see Note 4)

NOTE 4: All inputs are tied to 0V or VCC2. Outputs do not source or sink any current. The current consumption in LPM2 and LPM3 are measured with active Basic Timer1 Module (ACLK selected), LCD Module (f_{LCD}=1024Hz, 4MUX) and USART module (UART, ACLK, 2400 Baud selected)

Current Consumption of active mode versus system frequency, C versions only

I_{AM} = I_{AM[1MHz]} * f_{system}[MHz]

Current Consumption of active mode versus supply voltage, C versions only

 $I_{AM} = I_{AM[3V]} + 200\mu A/V * (V_{CC}-3)$



SLAS163 – FEBRUARY 1998

electrical characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (continued)

schmitt-trigger inputs Port 0 to P4, P0.x to P4.x, Timer/Port, CIN, TP0.0-TP0.5

	PARAMETER	TEST CONDITIONS	MIN	NOM MAX	UNIT
VIT+	Positive-going input threshold voltage	$V_{CC} = 3 V$	1.2	2.1	
		$V_{CC} = 5 V$	2.3	3.4]
VIT-	Negative-going input threshold voltage	$V_{CC} = 3 V$	0.7	1.5	
		$V_{CC} = 5 V$	1.4	2.3	ľ
VI-VO	Input-output voltage differential, (hysteresis)	$V_{CC} = 3 V$	0.3	1.0]
		$V_{CC} = 5 V$	0.6	1.4]

standard inputs TCK, TMS, TDI, RST/NMI (see Note 5)

	PARAMETER	TEST CONDITIONS	MIN	NOM MAX	UNIT
VIL	Low-level input voltage	Vcc = 3 V/5 V	VSS	V _{SS} +0.8	V
VIH	High-level input voltage	VCC = 3 V/5 V	0.7V _{CC}	VCC	v

NOTE 5: A serial resistor of 1kOhm to the RST/NMI is recommended to enhance latch-up immunity.

outputs Port 0 to P4, P0.x to P4.x, Timer/Port, TP0.0 to TP0.5, LCD: S2/O2 to S29/O29, XBUF: XBUF, JTAG: TDO

	PARAMETER	TEST CONDITIONS		MIN	NOM MAX	UNIT
		I(OHmax) = - 1.2 mA, See Note 6	V _{CC} = 3 V	V _{CC} -0.4	VCC	
V _{OH} High-level output voltage	I(OHmax) = - 3.5 mA, See Note 7	VCC = 3 V	V _{CC} -1.0	VCC	V	
I ^v OH	riigii-ievel output voitage	I(OHmax) = - 1.5 mA, See Note 6		V _{CC} -0.4	V _{CC}	v
		I(OHmax) = -4.5 mA, See Note 7	$V_{CC} = 5 V$	V _{CC} -1.0	V _{CC}	
		I(OLmax) = + 1.2 mA, See Note 6	Vec - 2 V	VSS	V _{SS} +0.4	
	Low-level output voltage	I(OLmax) = + 3.5 mA, See Note 7	VCC = 3 V	VSS	V _{SS} +1.0	V
V _{OL} Low-level output voltage	Low-level output voltage	I(OLmax) = + 1.5 mA, See Note 6		VSS	V _{SS} +0.4	v
		I _(OLmax) = + 4.5 mA, See Note 7	V _{CC} = 5 V	V _{SS}	V _{SS} +1.0	

NOTES: 6. The maximum total current for all outputs combined should not exceed ±9.6 mA to hold the maximum voltage drop specified. 7. The maximum total current for all outputs combined should not exceed ±28 mA to hold the maximum voltage drop specified.

leakage current (see Note 8)

	PARAMETER	TEST CONDIT	TIONS	MIN	NOM	MAX	UNIT
I _(LTP)	High-impendance leakage current (LTP)	V _{TP0.x, CIN} , see Note 9	$V_{CC} = 3 V/5 V$			± 50	nA
I(LS29)		$V_{S29} = VSS - VCC$	$V_{CC} = 3 V/5 V$			± 50	nA
I(P0.x)	Port P0: P0.x	$0 \le x \le 7$, see Note 10	$V_{CC} = 3 V/5 V$			± 50	nA
I(P0.x)	Port P1: P1.x	$0 \le x \le 7$, see Note 10	$V_{CC} = 3 V/5 V$			± 50	nA
I(P0.x)	Port P2: P2.x	$0 \le x \le 7$, see Note 10	$V_{CC} = 3 V/5 V$			± 50	nA
I(P0.x)	Port P3: P3.x	$0 \le x \le 7$, see Note 10	$V_{CC} = 3 V/5 V$			± 50	nA
I(P0.x)	Port P4: P4.x	$0 \le x \le 7$, see Note 10	$V_{CC} = 3 V/5 V$			± 50	nA

NOTES: 8. The leakage current is measured with VSS or VCC applied to the corresponding pins(s) - unless otherwise noted.

 All timer/port pins (TP0.0 to TP0.5) are Hi-Z. Pins CIN and TP0.0 to TP0.5 are connected together during leakage current measurement. In the leakage measurement mode, the input CIN is included. The input voltage is V_{SS} or V_{CC}.

10. The leakages of the digital port terminals are measured individually. The port terminal must be selected for input and there must be no optional pull–up or pull–down resistor.



SLAS163 - FEBRUARY 1998

electrical characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (continued)

optional resistors (see Note 11)

	PARAMETER	TEST CONDITIONS	MIN	NOM	MAX	UNIT
R _(opt1)		$V_{CC} = 3 V/5 V$	1.2	2.4	4.8	kΩ
R _(opt2)		$V_{CC} = 3 V/5 V$	1.8	3.6	7.2	kΩ
R _(opt3)		V _{CC} = 3 V/5 V	3.6	7.3	14.6	kΩ
R _(opt4)		$V_{CC} = 3 V/5 V$	5.5	11	22	kΩ
R _(opt5)	Resistors, individually programmable with ROM code, all port	$V_{CC} = 3 V/5 V$	11	22	44	kΩ
R _(opt6)	pins, values applicable for pull-down and pull-up	$V_{CC} = 3 V/5 V$	22	44	88	kΩ
R _(opt7)		$V_{CC} = 3 V/5 V$	33	66	132	kΩ
R _(opt8)		$V_{CC} = 3 V/5 V$	55	110	220	kΩ
R _(opt9)		$V_{CC} = 3 V/5 V$	77	154	310	kΩ
R _(opt10)		V _{CC} = 3 V/5 V	100	200	400	kΩ

NOTE 11: Optional resistors R(optx) for pull-down or pull-up are not programmed in standard OTP/EPROM devices P/E 337.

inputs and outputs

	PARAMETER	CONDITIONS	VCC	MIN	NOM	MAX	UNIT
^t (int)	External Interrupt timing	Port P0, P1 to P2: External trigger signal for the interrupt flag (see Notes 12 and 13)	3 V/ 5 V	1.5			cycle
t _(cap)	Timer_A, Capture timing	TA0-TA4 External capture signal (see Note 14)	3 V/ 5 V	250			ns
f(IN) t(H) or t(L) t(H) or t(L)	Input frequency	P0.1, CIN, TP.5, UCLK, SIMO, SOMI, TACLK, TA0-TA4	3 V/ 5 V 3 V 5 V	DC 300 125		^f (system)	Mhz ns ns
^f (XBUF) ^f (TAx) ^f (UCLK)	Output frequency	XBUF, $C_L = 20 \text{ pF}$ TA0-4, $C_L = 20 \text{ pF}$ UCLK, $C_L = 20 \text{ pF}$	3 V/ 5 V 3 V/ 5 V 3 V/ 5 V	DC DC		^f (system) ^f (system)/2 ^f (system)	MHz MHz
^t (Xdc) ^t (Xdc) ^t (Xdc) △t(TA) △ ^t (UC)	Duty cycle of output	$ \begin{array}{llllllllllllllllllllllllllllllllllll$	3 V/ 5 V 3 V/ 5 V 3 V/ 5 V 3 V/ 5 V 3 V/ 5 V	40 35	50 0 0	60 65 ±100 ±100	% % ns ns
$t(\tau)$	USART: Deglitch time	See Note 15	3 V 5 V	0.6 0.3		2.6 1.4	μs μs

NOTES: 12. The external signal sets the interrupt flag every time $t_{(int)}$ is met. It may be set even with trigger signals shorter than $t_{(int)}$. The conditions to set the flag must be met independently from this timing constraint. $T_{(int)}$ is defined in MCLK cycles.

13. The external interrupt signal cannot exceed the maximum input frequency (f(in))

14. The external capture signal triggers the capture event every time t_(cap) is met. It may be triggered even with capture signals shorter than t_(cap). The conditions to set the flag must be met independently from this timing constraint.

15. The signal applied to the USART receive signal/terminal (URXD) should meet the timing requirements of $t_{(t)}$ to ensure that the URXS flip-flop is set. The URXS flip-flop is set with negative pulses meeting the minimum timing condition of $t_{(t)}$. The operating conditions to set the flag must be met independently from this timing constraint. The deglitch circuitry is active only on negative transitions on the URXD line.



SLAS163 – FEBRUARY 1998

electrical characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (continued)

L	CD)
_		

PAR	AMETER	TEST CO	NDITIONS	MIN	NOM MAX	UNIT
V ₍₃₃₎		Voltage at R33		2.5	V _{CC} +0.2	
V ₍₂₃₎	Analog voltage	Voltage at R23	V _{CC} = 3 V/5 V		$_{3}-V_{03}) \times ^{2}/_{3} + V_{03}$	v
V ₍₁₃₎	Analog voltage	Voltage at R13	VCC = 3 V/3 V	(V ₍₃₃₎	$-V_{(03)}) \times \frac{1}{3} + V_{(03)}$	v
V ₍₀₃₎		Voltage at R03		V ₍₃₃₎ - 2.5	V _{CC} +0.2	
VO(HLCD)	Output 1	I _{(HLCD})<= 10 nA	V _{CC} = 3 V/5 V	V _(R33) - 0.125	VCC	V
VO(LLCD)	Output 0	I _(LLCD) <= 10 nA	VCC = 3 V/3 V	VSS	V _{SS} + 0.125	v
I(R03)		$R03 = V_{SS}$	No load at all		±20	
I(R13)	Input leakage	$R13 = V_{CC}/3$	segment and common lines,		±20	nA
I _(R23)		$R23 = 2 \times V_{CC}/3$	$V_{CC} = 3 V/5 V$		±20	
V _(Sxx0)				V ₍₀₃₎	V ₍₀₃₎ - 0.1	
V(Sxx1)	Segment line			V ₍₁₃₎	V ₍₁₃₎ – 0.1	v
V _(Sxx2)	voltage	I _(Sxx) =-3 μA,	$VCC = 3 \sqrt{3} \sqrt{3}$	V ₍₂₃₎	V ₍₂₃₎ - 0.1	, v
V _(Sxx3)				V ₍₃₃₎	V ₍₃₃₎ + 0.1	

POR

	PARAMETER	TEST CONDITION	IS	MIN	NOM	MAX	UNIT
t(POR) Delay					150	200	μs
V _(POR)				0.9		2.4	V
V(min_POR)			$V_{CC} = 3V/5V$	0		0.4	V
t(reset)	PUC/POR	Reset is accepted internally		2			μs

crystal oscillator, XIN, XOUT

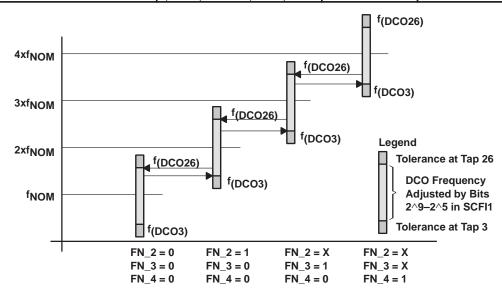
	PARAMETER	TEST CONDITIONS	MIN	NOM MAX	UNIT
C _(XIN)	Integrated capacitance at input			12	pF
C _(XOUT)	Integrated capacitance at output			12	pF
X _(INL)	Input levels	$V_{CC} = 3V/5V$	VSS	0.2 x VCC1	V
X _(INH)			0.8 x VCC1	VCC1	v



SLAS163 - FEBRUARY 1998

electrical characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (continued)

	PARAMETER	TEST CONDIT	IONS	MIN	NOM	MAX	UNIT
^f (NOM)	DCO	N(DCO) = 1 A0h FN_4=FN_3=FN_2 = 0	V _{CC} = 3 V/5 V		1		MHz
	4	O3) N(DCO) = 00 0110 0000 FN_4=FN_3=FN_2 = 0	V _{CC} = 3 V	0.15		0.6	MHz
£	f(DCO3)		$V_{CC} = 5 V$	0.18		0.62	
^f (NOM)	fun a a a a	N(DCO) = 11 0100 0000	$V_{CC} = 3 V$	1.25		4.7	MHz
	^f (DCO26)	$FN_4 = FN_3 = FN_2 = 0$	$V_{CC} = 5 V$	1.45		5.5	
	fra a a a	N _(DCO) = 00 0110 0000	$V_{CC} = 3 V$	0.36		1.05	MHz
^{2xf} (NOM)	f(DCO3)	FN_4=FN_3=0, FN_2 = 1	$V_{CC} = 5 V$	0.39		1.2	
	f(DCO26)	N(DCO) = 11 0100 0000	V _{CC} = 3 V	2.5		8.1	MHz
		FN_4=FN_3=0, FN_2 = 1	$V_{CC} = 5 V$	3		9.9	
	f(DCO3)	N(DCO) = 00 0110 0000	$V_{CC} = 3 V$	0.5		1.5	MHz
0.4		FN_4=0, FN_3=1, FN_2=X	$V_{CC} = 5 V$	0.6		1.8	
3xf(NOM)	^f (DCO26)	N(DCO) = 11 0100 0000	V _{CC} = 3 V	3.7		11	MHz
		FN_4=0,FN_3 =1, FN_2=X	$V_{CC} = 5 V$	4.5		13.8	
	^f (DCO3)	N(DCO) = 00 0110 0000	$V_{CC} = 3 V$	0.7		1.85	MHz
A		FN_4=1, FN_3 = FN_2=X	V _{CC} = 5 V	0.8		2.4	
^{4xf} (NOM)	4	N(DCO) = 11 0100 0000	V _{CC} = 3 V	4.8		13.3	
	f(DCO26)	FN_4=1, FN_3 = FN_2=X	V _{CC} = 5 V	6		17.7	MHz
N(DCO)		f(MCLK) = f(NOM) FN_4=FN_3=FN_2 = 0	V _{CC} = 3 V/5 V	A0h	1A0h	340h	
S		$f(NDCO)+1 = S \times f(NDCO)$	V _{CC} = 3 V/5 V	1.07		1.13	





SLAS163 - FEBRUARY 1998

electrical characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (continued)

RAM

PARAMETER	TEST CONDITIONS	MIN	NOM	MAX	UNIT
V(RAMh)	CPU halted, See Note 16	1.8			V

NOTE 16: This parameter defines the minimum supply voltage when the data in the program memory RAM remains unchanged. No program execution should happen during this supply voltage condition.

Timer/Port comparator

	PARAMETER	TE	MIN	NOM	MAX	UNIT	
			$V_{CC} = 3 V$		175	350	
l(CP)			$V_{CC} = 5 V$			600	μA
V _{ref(CP)}	Comparator, (timer/port)	CPON = 1	$V_{CC} = 3 V/5 V$	$0.230 \times V_{CC1}$		$0.260 \times V_{CC1}$	V
			V _{CC} = 3 V		5	37	mV
V _{hys} (CP)			$V_{CC} = 5 V$		10	42	mV

JTAG, program memory

	PARAMETER	TEST CONDITIONS	MIN	NOM	MAX	UNIT	
franci	ITAC/Toot	TCK frequency	$V_{CC} = 3 V$	DC		5	MHz
f(TCK)	JTAG/Test	TCK frequency	$V_{CC} = 5 V$	DC		10	IVITIZ
R _(test)		Pull-up resistors on TMS, TCK, TDI, See Note 17	V _{CC} = 3 V/ 5 V	25	60	90	kΩ
N/		Fuse blow voltage, C versions, See Note 19	$V_{CC} = 3 V/5 V$	5.5		6.0	
V(FB)	JTAG/Fuse,	Fuse blow voltage, E/P versions, See Note 19	$V_{CC} = 3 V/5 V$	11.0		12.0	
I _(FB)	See Note 18	Supply current on TDI/VPP to blow fuse				100	mA
^t (FB)]	Time to blow the fuse				1	ms
V _(PP)		Programming voltage, applied to TDI/VPP	$V_{CC} = 3 V/5 V$	11.0	11.5	12.0	V
I(PP)]	Current from programming voltage source	$V_{CC} = 3 V/5 V$			70	mA
t(pps)]	Programming time, single pulse	$V_{CC} = 3 V/5 V$	5			ms
t(ppf)		Programming time, fast algorithm	$V_{CC} = 3 V/5 V$		100		μs
Pn	EPROM(E) and OTP(P) versions only	Number of pulses for successful programming	$V_{CC} = 3 V/5 V$	4		100	
^t (erase)		Erase time wave length 2537 Å @ 15 Ws/cm ² (UV lamp of 12 mW/ cm ²)		30			min
	1	Write/erase cycles		1000			
	1	Data retention Tj <55°C		10			Year

NOTES: 17. The TMS and TCK pull-up resistors are implemented in all ROM(C), OTP(P) and EPROM(E) versions. The pull-up resistor on TDI is implemented in C versions only.

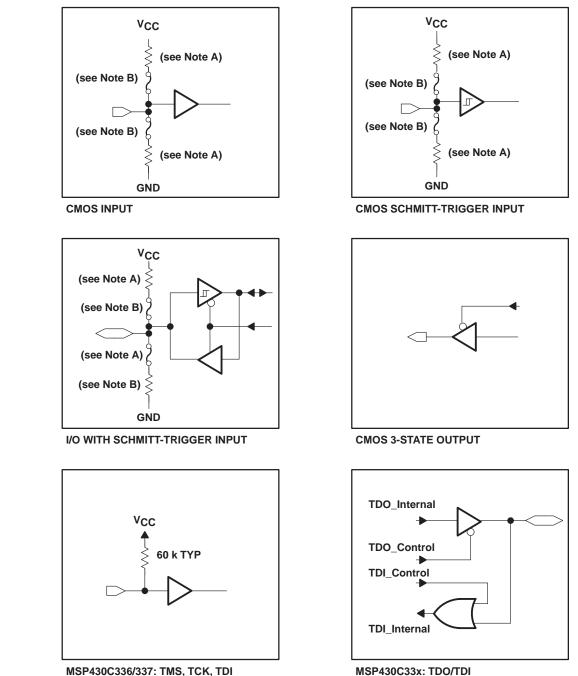
18. Once the fuse is blown no further access to the MSP430 JTAG/Test feature is possible.

19. The voltage supply to blow the fuse is applied to TDI/VPP pin during the fuse blowing procedure.



SLAS163 - FEBRUARY 1998

APPLICATION INFORMATION



MSP430P336/E337: TMS, TCK

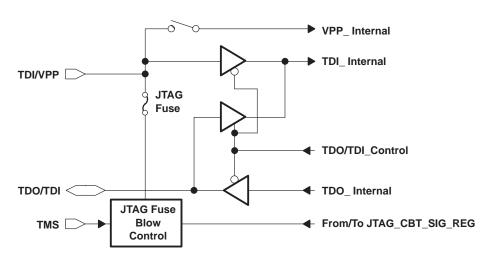
NOTES: A. Optional selection of pull-up or pull-down resistors available on ROM (masked) versions.

MSP430P/E33x: TDO/TDI

B. Fuses for the optional pull-up and pull-down resistors can only be programmed at the factory.



SLAS163 - FEBRUARY 1998



APPLICATION INFORMATION

Figure 3. MSP430P337/E337: TDI/VPP, TDO/TDI

- NOTES: A. During programming activity and when blowing the JTAG fuse, the TDI/VPP terminal is used to apply the correct voltage source. The TDO/TDI terminal is used to apply the test input data for JTAG circuitry.
 - B. The TDI/VPP terminal of the 'P337 and 'E337 does not have an internal pull-up resistor. An external pull-down resistor is recommended to avoid a floating node which could increase the current consumption of the device.
 - C. The TDO/TDI terminal is in a high-impedance state after POR. The 'P337 and 'E337 needs a pull-up or a pull-down resistor to avoid floating a node which could increase the current consumption of the device.

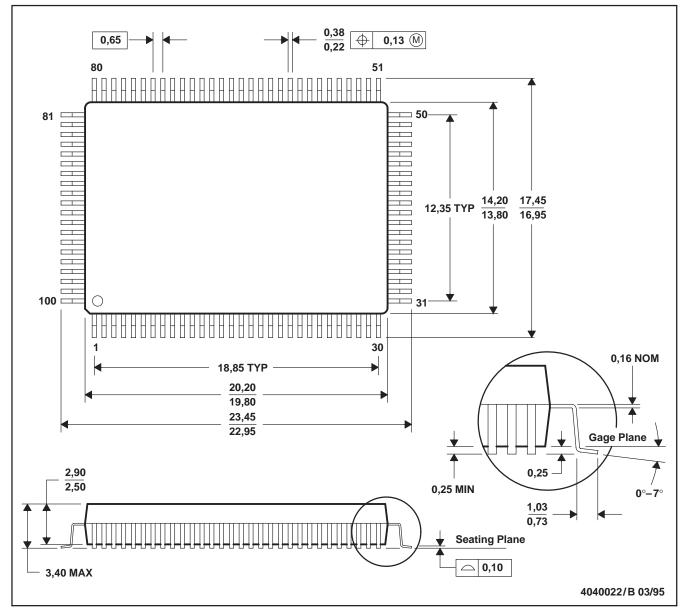


SLAS163 - FEBRUARY 1998

MECHANICAL DATA

PLASTIC QUAD FLATPACK

PJM (R-PQFP-G100)



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Falls within JEDEC MS-022

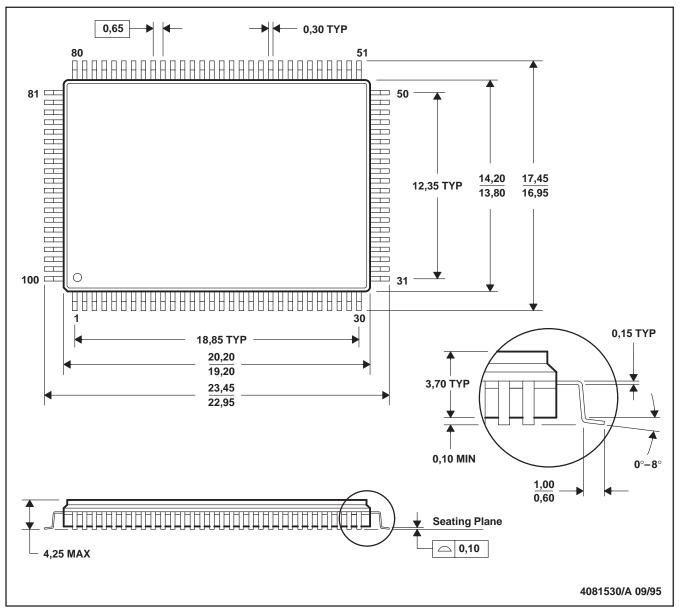


SLAS163 - FEBRUARY 1998

MECHANICAL DATA

HFD (S-GQFP-G100)

CERAMIC QUAD FLATPACK



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.



www.ti.com

PACKAGING INFORMATION

RUMENTS

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins Pa	ackage Qty	Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
MSP-EVK430A330	OBSOLETE			0		TBD	Call TI	Call TI
MSP-EVK430B330	OBSOLETE			0		TBD	Call TI	Call TI
MSP430P337IPJM	ACTIVE	QFP	PJM	100	66 (Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR
PMS430E337AHFD	ACTIVE	CFP	HFD	100	1	TBD	Call TI	Level-1-220C-UNLIM
PMS430E337HFD	OBSOLETE	CFP	HFD	100		TBD	Call TI	Call TI

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

Important Information and Disclaimer:The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

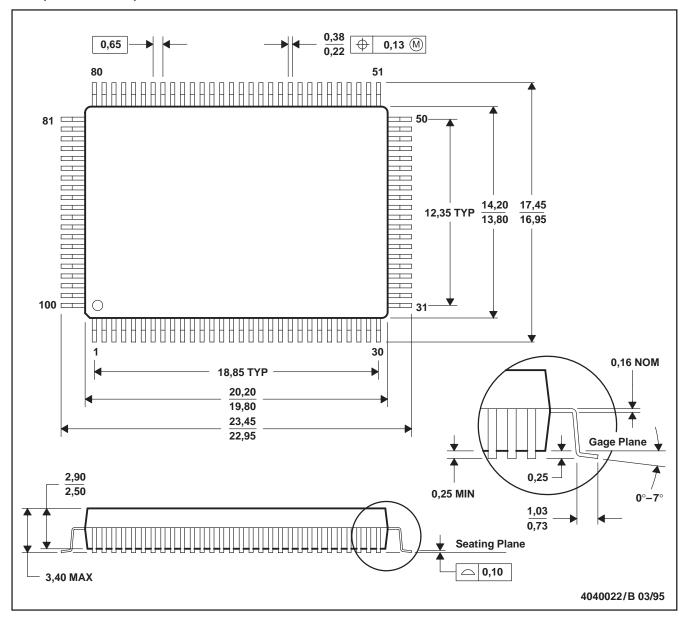
In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

MECHANICAL DATA

MQFP013 - OCTOBER 1994

PJM (R-PQFP-G100)

PLASTIC QUAD FLATPACK



- NOTES: A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Falls within JEDEC MS-022



IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, modifications, enhancements, improvements, and other changes to its products and services at any time and to discontinue any product or service without notice. Customers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All products are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its hardware products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by government requirements, testing of all parameters of each product is not necessarily performed.

TI assumes no liability for applications assistance or customer product design. Customers are responsible for their products and applications using TI components. To minimize the risks associated with customer products and applications, customers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any TI patent right, copyright, mask work right, or other TI intellectual property right relating to any combination, machine, or process in which TI products or services are used. Information published by TI regarding third-party products or services does not constitute a license from TI to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. Reproduction of this information with alteration is an unfair and deceptive business practice. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI products or services with statements different from or beyond the parameters stated by TI for that product or service voids all express and any implied warranties for the associated TI product or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

TI products are not authorized for use in safety-critical applications (such as life support) where a failure of the TI product would reasonably be expected to cause severe personal injury or death, unless officers of the parties have executed an agreement specifically governing such use. Buyers represent that they have all necessary expertise in the safety and regulatory ramifications of their applications, and acknowledge and agree that they are solely responsible for all legal, regulatory and safety-related requirements concerning their products and any use of TI products in such safety-critical applications, notwithstanding any applications-related information or support that may be provided by TI. Further, Buyers must fully indemnify TI and its representatives against any damages arising out of the use of TI products in such safety-critical applications.

TI products are neither designed nor intended for use in military/aerospace applications or environments unless the TI products are specifically designated by TI as military-grade or "enhanced plastic." Only products designated by TI as military-grade meet military specifications. Buyers acknowledge and agree that any such use of TI products which TI has not designated as military-grade is solely at the Buyer's risk, and that they are solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI products are neither designed nor intended for use in automotive applications or environments unless the specific TI products are designated by TI as compliant with ISO/TS 16949 requirements. Buyers acknowledge and agree that, if they use any non-designated products in automotive applications, TI will not be responsible for any failure to meet such requirements.

Following are URLs where you can obtain information on other Texas Instruments products and application solutions:

Products		Applications	
Amplifiers	amplifier.ti.com	Audio	www.ti.com/audio
Data Converters	dataconverter.ti.com	Automotive	www.ti.com/automotive
DLP® Products	www.dlp.com	Broadband	www.ti.com/broadband
DSP	dsp.ti.com	Digital Control	www.ti.com/digitalcontrol
Clocks and Timers	www.ti.com/clocks	Medical	www.ti.com/medical
Interface	interface.ti.com	Military	www.ti.com/military
Logic	logic.ti.com	Optical Networking	www.ti.com/opticalnetwork
Power Mgmt	power.ti.com	Security	www.ti.com/security
Microcontrollers	microcontroller.ti.com	Telephony	www.ti.com/telephony
RFID	www.ti-rfid.com	Video & Imaging	www.ti.com/video
RF/IF and ZigBee® Solutions	www.ti.com/lprf	Wireless	www.ti.com/wireless

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2009, Texas Instruments Incorporated